Search Notes



Application/Control	No.

Applicant(s)/Patent under Reexamination TANAKA, KOICHIRO Art Unit

10/021,719 Examiner

2818

DUNG A. LE

SEARCHED				
Class	Subclass	Date	Examiner	
438	166	3/18/2005	DLE	
	487			
	308			
	378			
	795 ·			
219	121.65			
	121.76			
	,			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
IEEE,PGPUB,JPO,EPO,EAST, IMB	3/18/2005	DLE	
438/166,306,378,795 Interference search	10/28/2005	DLE	
EAST: TEX SEARCH 438/166,306,378,795 Interference search	5/23/2006	DLE	
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